

<b>Notice of References Cited</b>	Application/Control No. 10/615,418	Applicant(s)/Patent Under Reexamination NOWOTNY ET AL.	
	Examiner Sean P. Shechtman	Art Unit 2125	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,526,836	09-1970	DEGER ERTURK; et. al.	324/73.1
*	B	US-4,589,554	05-1986	Edelbruck et al.	209/546
*	C	US-6,720,194	04-2004	Miller et al.	438/14
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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